

**Search Notes****Application/Control No.**

10/820,245

**Examiner**

Pho M. Luu

**Applicant(s)/Patent under Reexamination**

BYEON ET AL.

**Art Unit**

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	195	8/1/2005	PL
365	189.07	8/1/2005	PL
365	189.05	8/1/2005	PL
365	189.12	8/1/2005	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB) See Search Printout	8/1/2005	PL
Consulted With Primary VanThu Nguyen	8/1/2005	PL
Interference Search See Printout	8/1/2005	PL
365/195 (text search only) see Printout	8/1/2005	PL

**INTERFERENCE SEARCHED**

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365	189.12	8/1/2005	PL